



40V N-CHANNEL ENHANCEMENT MODE MOSFET

Product Summary

BV _{DSS}	R _{DS(ON)}	I _D T _A = +25°C
40)/	30mΩ @V _{GS} = 10V	13.7A
40V	50mΩ @V _{GS} = 4.5V	10.6A

Description and Applications

This MOSFET is designed to meet the stringent requirements of Automotive applications. It is qualified to AEC-Q101, supported by a PPAP and is ideal for use in:

- Backlighting
- DC-DC Converters
- · Power Management Functions

Features

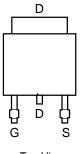
- Low On-Resistance
- · Fast Switching Speed
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- Qualified to AEC-Q101 Standards for High Reliability
- PPAP Capable (Note 4)

Mechanical Data

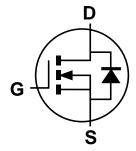
- Case: TO252 (DPAK)
- Case Material: Molded Plastic, "Green" Molding Compound. UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals: Matte Tin Finish Annealed over Copper Leadframe.
 Solderable per MIL-STD-202, Method 208 ©3
- Weight: 0.33 grams (Approximate)



Top View



Top View Pin-Out



Equivalent Circuit

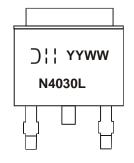
Ordering Information (Note 5)

Part Number	Case	Packaging
DMN4030LK3Q-13	TO252 (DPAK)	2,500/Tape & Reel

Notes:

- 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.
- See http://www.diodes.com/quality/lead_free.html for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. Automotive products are AEC-Q101 qualified and are PPAP capable. Refer to https://www.diodes.com/quality/product-compliance-definitions/
- 5. For packaging details, go to our website at https://www.diodes.com/design/support/packaging/diodes-packaging/.

Marking Information



>\\\ = Manufacturer's Marking
N4030L = Product Type Marking Code
YYWW = Date Code Marking
YY = Year (ex: 17 = 2017)
WW = Week (01 to 53)



Maximum Ratings (@T_A = +25°C, unless otherwise specified.)

Characteristic			Symbol	Value	Unit
Drain-Source Voltage			V _{DSS}	40	V
Gate-Source Voltage			V _{GSS}	±20	V
Continuous Drain Current (Note 7) V _{GS} = 10V	I _D	13.7 10.9	А		
Continuous Drain Current (Note 6) V _{GS} = 10V			I _D	9.4	Α
Maximum Body Diode Continuous Current (Note 7)			I _S	10.7	Α
Pulsed Drain Current (10µs Pulse, Duty Cycle = 1%) (Note 8)			I _{DM}	37.7	Α
Pulsed Source Current (10µs Pulse, Duty Cycle = 1%) (Note 8)			I _{SM}	37.7	Α

Thermal Characteristics (@T_A = +25°C, unless otherwise specified.)

Characteristic		Symbol	Value	Unit
Total Power Dissipation (Note 6)	T _A = +25°C	P_{D}	4.18	W
Thermal Resistance, Junction to Ambient (Note 6)	Steady State	R _{0JA}	29.9	°C/W
Total Power Dissipation (Note 7)	T _A = +25°C	P _D	8.9	W
Thermal Resistance, Junction to Ambient (Note 7)	T _A = +25°C	$R_{\theta JA}$	14.0	°C/W
Thermal Resistance, Junction to Case (Note 10)		Rejc	2.46	C/VV
Total Power Dissipation (Note 9)	T _A = +25°C	P _D	2.14	W
Thermal Resistance, Junction to Ambient (Note 9)	Steady State	R _{0JA}	58.4	°C/W
Operating and Storage Temperature Range		$T_{J_1}T_{STG}$	-55 to +150	°C

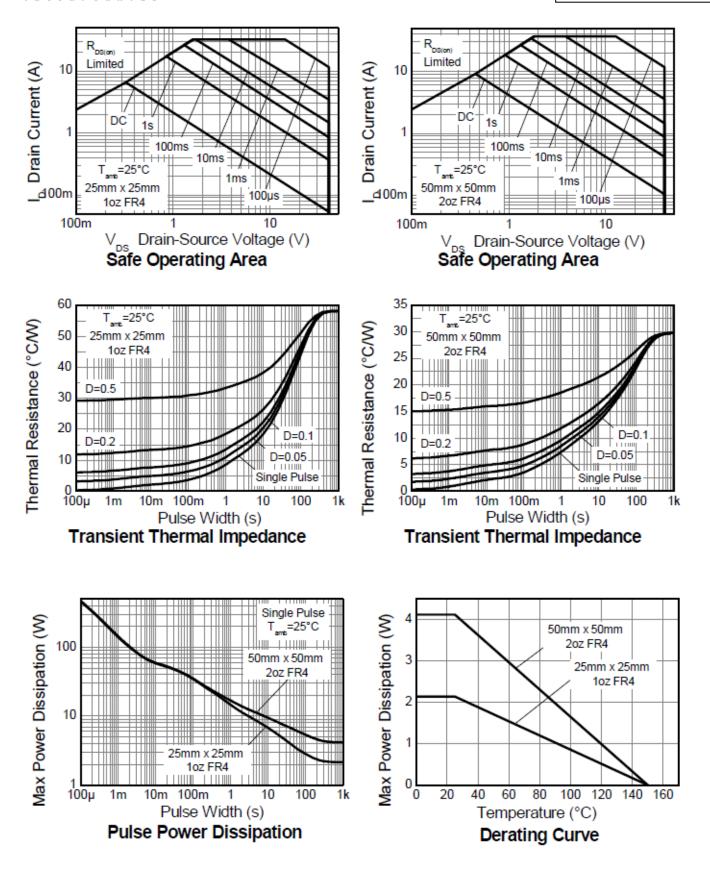
Electrical Characteristics (@TA = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition	
OFF CHARACTERISTICS (Note 11)							
Drain-Source Breakdown Voltage	BV _{DSS}	40	_		V	$V_{GS} = 0V, I_D = 250\mu A$	
Zero Gate Voltage Drain Current	I _{DSS}	_		1	μA	$V_{DS} = 40V, V_{GS} = 0V$	
Gate-Source Leakage	I _{GSS}	_	_	±100	nA	$V_{GS} = \pm 20V, V_{DS} = 0V$	
ON CHARACTERISTICS (Note 11)							
Gate Threshold Voltage	V _{GS(TH)}	1		3	V	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	
Static Drain-Source On-Resistance		_	21	30	mΩ	$V_{GS} = 10V, I_D = 12A$	
Static Dialif-Source Off-Resistance	R _{DS(ON)}	_	37	50	11122	$V_{GS} = 4.5V, I_D = 6A$	
Diode Forward Voltage	V_{SD}	_	0.95	1.1	V	$V_{GS} = 0V, I_{S} = 12A$	
DYNAMIC CHARACTERISTICS (Note 12)							
Input Capacitance	Ciss	_	604	_		V _{DS} = 20V, V _{GS} = 0V, f = 1.0MHz	
Output Capacitance	Coss	_	106	_	pF		
Reverse Transfer Capacitance	C_{rss}	_	59.6	_			
Total Gate Charge (V _{GS} = 4.5V)	Q_g	_	6.5	_		V 00V L 40A	
Total Gate Charge (V _{GS} = 10V)	Q_g	_	12.9	_	nC		
Gate-Source Charge	Q_{gs}	_	2.3	_	IIC	$V_{DS} = 20V, I_{D} = 12A$	
Gate-Drain Charge	Q_{gd}	_	3.6	_			
Turn-On Delay Time	t _{D(ON)}	_	4.2	_		$V_{DD} = 20V, I_D = 12A$ $V_{GS} = 10V, R_G = 6\Omega$	
Turn-On Rise Time	t _R	_	12.4	_			
Turn-Off Delay Time	t _{D(OFF)}	_	13.8	_	ns		
Turn-Off Fall Time	t _F	_	10.7				
Body Diode Reverse Recovery Time	t _{RR}	_	135		ns	I _F = 12A, di/dt = 100A/μs	
Body Diode Reverse Recovery Charge	Q_{RR}	_	799	_	nC	$I_F = 12A$, $di/dt = 100A/\mu s$	

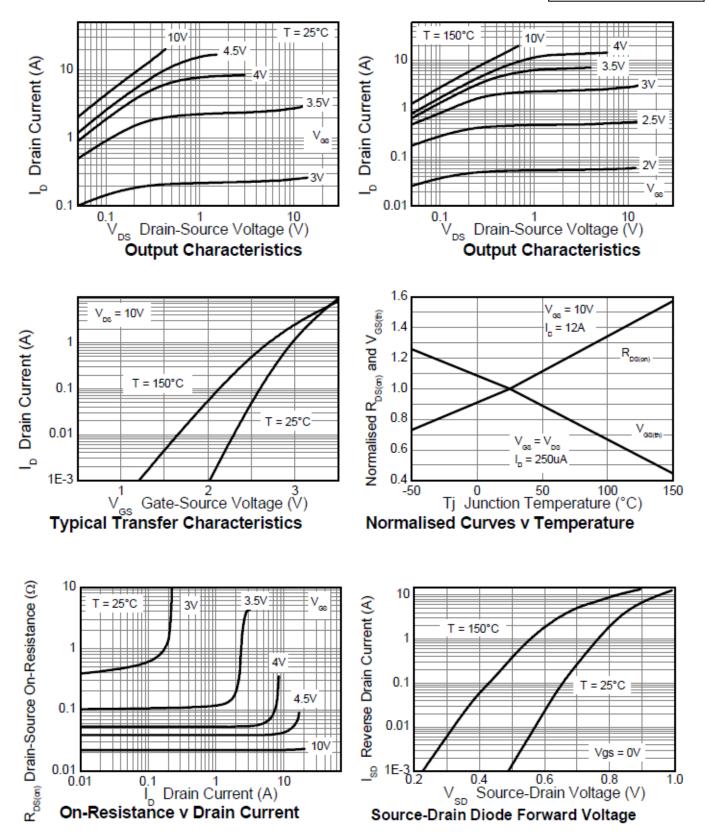
Notes: 6. For a device surface mounted on 50mm x 50mm x 1.6mm FR-4 PCB with high coverage of single sided 2oz copper, in still air conditions; the device is measured when operating in a steady-state condition.

- 7. Same as note 6, except the device is measured at $t \le 10$ sec.
- 8. Same as note 6, except the device is pulsed with D = 0.02 and pulse width 300µs. The pulse current is limited by the maximum junction temperature.
- 9. For a device surface mounted on 25mm x 25mm x 1.6mm FR-4 PCB with high coverage of single sided 1oz copper, in still air conditions; the device is measured when operating in a steady-state condition.
- 10. Thermal resistance from junction to solder-point (at the end of the drain lead).
- 11. Short duration pulse test used to minimize self-heating effect.
- 12. Guaranteed by design. Not subject to product testing.

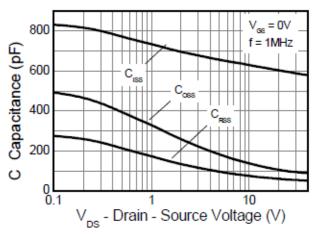


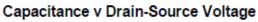


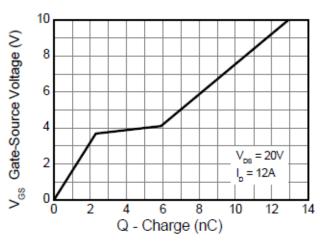










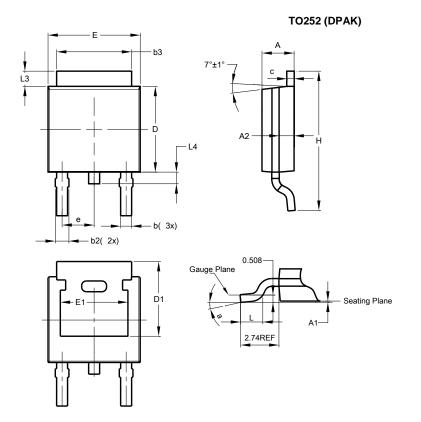


Gate-Source Voltage v Gate Charge



Package Outline Dimensions

Please see http://www.diodes.com/package-outlines.html for the latest version.

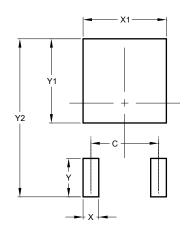


TO252 (DPAK)					
Dim	Min	Max	Тур		
Α	2.19	2.39	2.29		
A 1	0.00	0.13	0.08		
A2	0.97	1.17	1.07		
b	0.64	0.88	0.783		
b2	0.76	1.14	0.95		
b3	5.21	5.46	5.33		
С	0.45	0.58	0.531		
D	6.00	6.20	6.10		
D1	5.21	-	-		
е	-	-	2.286		
Е	6.45	6.70	6.58		
E1	4.32	-	-		
Н	9.40	10.41	9.91		
L	1.40	1.78	1.59		
L3	0.88	1.27	1.08		
L4	0.64	1.02	0.83		
а	0°	10°	-		
All Dimensions in mm					

Suggested Pad Layout

Please see http://www.diodes.com/package-outlines.html for the latest version.

TO252 (DPAK)



Dimensions	Value (in mm)				
С	4.572				
Х	1.060				
X1	5.632				
Υ	2.600				
Y1	5.700				
Y2	10.700				



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